

SLVSAE2A-JULY 2010-REVISED FEBRUARY 2012

HIGH-PERFORMANCE CURRENT-MODE PWM CONTROLLER

Check for Samples: TL2843B-Q1

FEATURES

- Qualified for Automotive Applications
- Low Start-Up Current (<0.5 mA)
- Trimmed Oscillator Discharge Current
- Current Mode Operation to 500 kHz
- Automatic Feed-Forward Compensation
- Latching PWM for Cycle-by-Cycle Current Limiting
- Internally Trimmed Reference With Undervoltage Lockout
- High-Current Totem-Pole Output Undervoltage
 Lockout With Hysteresis
- Double-Pulse Suppression

DESCRIPTION

The TL284xB series of control integrated circuits provide the features that are necessary to implement off-line or dc-to-dc fixed-frequency current-mode control schemes, with a minimum number of external components. Internally implemented circuits include an undervoltage lockout (UVLO) and a precision reference that is trimmed for accuracy at the error amplifier input. Other internal circuits include logic to ensure latched operation, a pulse-width modulation (PWM) comparator that also provides current-limit control, and a totem-pole output stage designed to source or sink high-peak current. The output stage, suitable for driving N-channel MOSFETs, is low when it is in the off state.

The TL284xB series are pin compatible with the standard TL284x with the following improvements. The start-up current is specified to be 0.5 mA (max), while the oscillator discharge current is trimmed to 8.3 mA (typ). In addition, during undervoltage lockout conditions, the output has a maximum saturation voltage of 1.2 V while sinking 10 mA ($V_{CC} = 5$ V).

Major differences between members of these series are the UVLO thresholds and maximum duty-cycle ranges. Typical UVLO thresholds of 16 V (on) and 10 V (off) on the TL2842B and TL2844B devices make them ideally suited to off-line applications. The corresponding typical thresholds for the TL2843B and TL2845B devices are 8.4 V (on) and 7.6 V (off). The TL2842B and TL2843B devices can operate to duty cycles approaching 100%. A duty-cycle range of 0% to 50% is obtained by the TL2844B and TL2845B by the addition of an internal toggle flip-flop, which blanks the output off every other clock cycle. The TL284xB-series devices are characterized for operation from -40° C to 125°C.

T _A	PACKAGE ⁽²⁾		PACKAGE ⁽²⁾ ORDERABLE PART NUMBER	
			TL2842BQDRQ1	Product Preview
–40°C to 125°C		Reel of 2500	TL2843BQDRQ1	TL2843BQ
	SOIC – D		TL2844BQDRQ1	Product Preview
			TL2845BQDRQ1	Product Preview

Table 1. ORDERING INFORMATION⁽¹⁾

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



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NC - No internal connection

TL2843B-Q1



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



FUNCTIONAL BLOCK DIAGRAM

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ABSOLUTE MAXIMUM RATINGS⁽¹⁾ ⁽²⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{cc}	Supply voltage	Low impedance source		30	
		I _{CC} < 30 mA		Self limiting	V
VI	Analog input voltage range	VFB and I _{SENSE}	-0.3	6.3	V
I _{CC}	Supply current			30	mA
I _O	Output current			±1	А
I _{O(sink)}	Error amplifier output sink current			10	mA
θ_{JA}	Package thermal impedance ^{(3) (4)}	D package		97	°C/W
	Output energy	Capacitive load		5	μJ
TJ	Virtual junction temperature			150	°C
T _{stg}	Storage temperature range		-65	150	°C

 Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to the device GND terminal.

(3) Maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(max) - T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can impact reliability.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

RECOMMENDED OPERATING CONDITIONS

			MIN	NOM	MAX	UNIT
V	Supply voltogo	V _{CC}			30	V
VCC	Supply voltage	VC ⁽¹⁾			30	v
VI	Input voltogo	R _T /C _T	0		5.5	
	Input voltage	VFB and I _{SENSE}	0		5.5	v
	Output voltage	OUTPUT	0		30	V
۷O	Oulput voltage	POWER GROUND ⁽¹⁾	-0.1		1	
I _{CC}	Supply current, externally limited				25	mA
lo	Average output current				200	mA
I _{O(ref)}	Reference output current				-20	mA
f _{osc}	Oscillator frequency			100	500	kHz
T _A	Operating free-air temperature		-40		125	°C

(1) The recommended voltages for VC and POWER GROUND apply only to the 14-pin D package.

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TRUMENTS

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REFERENCE SECTION ELECTRICAL CHARACTERISTICS

 V_{CC} = 15 V⁽¹⁾, R_T = 10 k Ω , C_T = 3.3 nF, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED		TL284xB			
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
Output voltage	$I_O = 1 \text{ mA}, T_J = 25^{\circ}C$	4.95	5	5.05	V
Line regulation	V_{CC} = 12 V to 25 V		6	20	mV
Load regulation	$I_0 = 1 \text{ mA to } 20 \text{ mA}$		6	25	mV
Average temperature coefficient of output voltage			0.2	0.4	mV/°C
Output voltage, worst-case variation	$V_{CC} = 12$ V to 25 V, $I_{O} = 1$ mA to 20 mA	4.9		5.1	V
Output noise voltage	f = 10 Hz to 10 kHz, $T_J = 25^{\circ}C$		50		μV
Output-voltage long-term drift	After 1000 h at $T_J = 25^{\circ}C$		5	25	mV
Short-circuit output current		-30	-100	-180	mA

Adjust V_{CC} above the start threshold before setting it to 15 V. (1)

(2) All typical values are at $T_J = 25^{\circ}C$.

OSCILLATOR SECTION⁽¹⁾ ELECTRICAL CHARACTERISTICS

 V_{CC} = 15 $V^{(2)}$, R_T = 10 k Ω , C_T = 3.3 nF, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED	TEST CONDITIONS	TL284xB			LINUT
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽³⁾	MAX	UNIT
	$T_J = 25^{\circ}C$	49	52	55	
Initial accuracy	$T_A = T_{low}$ to T_{high}	48		56	kHz
	$T_J = 25^{\circ}C, R_T = 6.2 \text{ k}\Omega, C_T = 1 \text{ nF}$	225	250	275	
Voltage stability	$V_{CC} = 12 \text{ V to } 25 \text{ V}$		0.2	1	%
Temperature stability			5		%
Amplitude	Peak to peak		1.7		V
Discharge current ⁽⁴⁾	$T_{\rm J} = 25^{\circ} {\rm C}, \ {\rm R}_{\rm T} / {\rm C}_{\rm T} = 2 \ {\rm V}$	7.8	8.3	8.8	
	$R_T/C_T = 2 V$	7.5		8.8	ША

(1) Output frequency equals oscillator frequency for the TL2842B and TL2843B. Output frequency is one-half the oscillator frequency for the TL2844B and TL2845B.

Adjust V_{CC} above the start threshold before setting it to 15 V. All typical values are at $T_J = 25^{\circ}$ C. (2)

(3)

(4) Specified by design. Not production tested.



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ERROR-AMPLIFIER SECTION ELECTRICAL CHARACTERISTICS

 V_{CC} = 15 V⁽¹⁾, R_T = 10 k Ω , C_T = 3.3 nF, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED					
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
Feedback input voltage	COMP = 2.5 V	2.45	2.5	2.55	V
Input bias current			-0.3	-1	μA
Open-loop voltage amplification	$V_0 = 2 V \text{ to } 4 V$	65	90		dB
Gain-bandwidth product		0.7	1		MHz
Supply-voltage rejection ratio	$V_{CC} = 12 \text{ V to } 25 \text{ V}$	60	70		dB
Output sink current	VFB = 2.7 V, COMP = 1.1 V	2	6		mA
Output source current	VFB = 2.3 V, COMP = 5 V	-0.5	-0.8		mA
High-level output voltage	VFB = 2.3 V, R_L = 15 k Ω to GND	5	6		V
Low-level output voltage	VFB = 2.7 V, R_L = 15 k Ω to GND		0.7	1.1	V

(1) Adjust V_{CC} above the start threshold before setting it to 15 V.

(2) All typical values are at $T_J = 25^{\circ}C$.

CURRENT-SENSE SECTION ELECTRICAL CHARACTERISTICS

 V_{CC} = 15 V⁽¹⁾, R_T = 10 k Ω , C_T = 3.3 nF, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED	TEST CONDITIONS		LINUT			
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	МАХ	UNIT	
Voltage amplification ^{(3) (4)}		2.85	3	3.15	V/V	
Current-sense comparator threshold ⁽³⁾	COMP = 5 V	0.9	1	1.1	V	
Supply-voltage rejection ratio ⁽³⁾	V_{CC} = 12 V to 25 V		70		dB	
Input bias current			-2	-10	μA	
Delay time to output ⁽⁵⁾	VFB = 0 V to 2 V		150	300	ns	

Adjust V_{CC} above the start threshold before setting it to 15 V. All typical values are at $T_J = 25^{\circ}C$. (1)

(2)

(3) Measured at the trip point of the latch, with VFB at 0 V.

Measured between I_{SENSE} and COMP, with the input changing from 0 V to 0.8 V. Specified by design. Not production tested. (4)

(5)



Output Section Electrical Characteristics

 V_{CC} = 15 V⁽¹⁾, R_T = 10 k Ω , C_T = 3.3 nF, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED	TEAT CONDITIONS		TL284xB			
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT	
High-level output voltage	I _{OH} = -20 mA	13	13.5		V	
	I _{OH} = -200 mA	12	13.5		v	
	I _{OL} = 20 mA		0.1	0.4	V	
Low-level output voltage	I _{OL} = 200 mA		1.5	2.2	v	
Rise time ⁽³⁾	$C_{L} = 1 \text{ nF}, T_{J} = 25^{\circ}C$		50	150	ns	
Fall time ⁽³⁾	$C_{L} = 1 \text{ nF}, T_{J} = 25^{\circ}C$		50	150	ns	
UVLO saturation ⁽³⁾	$V_{CC} = 5 V, I_{OL} = 1 mA$		0.7	1.2	V	

(1) Adjust V_{CC} above the start threshold before setting it to 15 V.

(2) All typical values are at $T_J = 25^{\circ}C$.

(3) Specified by design. Not production tested.

UNDERVOLTAGE-LOCKOUT SECTION ELECTRICAL CHARACTERISTICS

 $V_{CC} = 15 V^{(1)}$, $R_T = 10 k\Omega$, $C_T = 3.3 nF$, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED	TEST CONDITIONS				
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
Start threshold voltage		7.8	8.4	9	V
Minimum operating voltage after start-up		7	7.6	8.2	V

(1) Adjust V_{CC} above the start threshold before setting it to 15 V.

(2) All typical values are at $T_J = 25^{\circ}C$.

PULSE-WIDTH MODULATOR SECTION ELECTRICAL CHARACTERISTICS

 V_{CC} = 15 V⁽¹⁾, R_T = 10 k Ω , C_T = 3.3 nF, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED	TEST CONDITIONS				
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
Maximum duty cycle ⁽³⁾		94	96	100	%
Minimum duty cycle				0	%

(1) Adjust V_{CC} above the start threshold before setting it to 15 V.

(2) All typical values are at $T_J = 25^{\circ}C$.

(3) Specified by design. Not production tested.

SUPPLY VOLTAGE ELECTRICAL CHARACTERISTICS

 $V_{CC} = 15 V^{(1)}$, $R_T = 10 k\Omega$, $C_T = 3.3 nF$, over recommended operating free-air temperature range (unless otherwise specified)

DADAMETED	TEST CONDITIONS	TL284xB			
PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
Start-up current			0.3	0.5	mA
Operating supply current	VFB and I _{SENSE} at 0 V		11	17	mA
Limiting voltage	$I_{CC} = 25 \text{ mA}$	30	34		V

(1) Adjust V_{CC} above the start threshold before setting it to 15 V.

(2) All typical values are at $T_J = 25^{\circ}C$.







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APPLICATION INFORMATION

The error-amplifier configuation circuit is shown in Figure 1.



A. Error amplifier can source or sink up to 0.5 mA.



The current-sense circuit is shown in Figure 2.



- A. Peak current (I_S) is determined by the formula: $I_{S(max)} = 1 \text{ V/R}_S$
- B. A small RC filter formed by resistor R_f and capacitor C_f may be required to suppress switch transients.

Figure 2. Current-Sense Circuit

The oscillator frequency is set using the circuit shown in Figure 3. The frequency is calculated as: $f = 1 / R_T C_T$

For R_T > 5 kΩ: f ≉ 1.72 / R_TC_T



Figure 3. Oscillator Section

10 Submit Documentation Feedback





Open-Loop Laboratory Test Fixture

In the open-loop laboratory test fixture (see Figure 4), high peak currents associated with loads necessitate careful grounding techniques. Timing and bypass capacitors should be connected close to the GND terminal in a single-point ground. The transistor and 5-k Ω potentiometer sample the oscillator waveform and apply an adjustable ramp to the I_{SENSE} terminal.



Figure 4. Open-Loop Laboratory Test Fixture



Shutdown Technique

The PWM controller (see Figure 5) can be shut down by two methods: either raise the voltage at I_{SENSE} above 1 V or pull the COMP terminal below a voltage two diode drops above ground. Either method causes the output of the PWM comparator to be high (see the *Functional Block Diagram*). The PWM latch is reset dominant so that the output remains low until the next clock cycle after the shutdown condition at the COMP or I_{SENSE} terminal is removed. In one example, an externally latched shutdown can be accomplished by adding an SCR that resets by cycling V_{CC} below the lower UVLO threshold. At this point, the reference turns off, allowing the SCR to reset.



Figure 5. Shutdown Techniques

A fraction of the oscillator ramp can be summed resistively with the current-sense signal to provide slope compensation for converters requiring duty cycles over 50% (see Figure 6). Note that capacitor C forms a filter with R2 to suppress the leading-edge switch spikes.



Figure 6. Slope Compensation



REVISION HISTORY

Cł	hanges from Original (July 2012) to Revision A Pag					
•	Changed the pinout from an 8-pin to 14-pin D package	. 1				
•	Changed the Functional Block diagram pin numbers for the 14-pin D package	. 2				



6-Feb-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
TL2843BQDRQ1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TL2843BQ	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF TL2843B-Q1 :



PACKAGE OPTION ADDENDUM

6-Feb-2020

Catalog: TL2843B

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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